Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/799,786	NAKANO ET AL.	
Examiner	Art Unit	-
Erin D. Chiem	2883	

	SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated search - see EAST history	12/26/2006	EDC		